

Notice of References Cited

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Application/Control No.	Applicant(s)/	Patent Under	
09/530,008	Reexamination KANEKO ET AL.		
Examiner	Art Unit		
HOAN C. NGUYEN	2871	Page 1 of 1	

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6437843	08-2002	Van De Witte et al.	349/117
	В	US-5793455	08-1998	Nakamura	349/96
	С	US-5855971	12-1996	Ito et al.	349/118
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	Н	US-			
	I	US-			
	J	US-		,	
	К	US-			
1	Ł	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	JP03294821	04-1990	JP	Shigeki et al.	
	0					
	Р					
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

MONTALENT DOCUMENTS				
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)		
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	V			
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	x			

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